

Application/Control No.	Applicant(s)/Patent under Reexamination
10/658,466	SHIRAISHI ET AL.
Examiner	Art Unit
lason I Lazorcik	1731

	SEARCHED				
Class	Subclass	Date	Examiner		
			·		
		3 11 11			

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Inventor search completed: -Shiraishi, Koichiro - OHMI, SHIGEAKI	4/24/2006	JLL
65/24,26,30.1,60.1,60.3,60.6,60.3,64, 111,102,374.15 427/450,535,539,577,165 (* limited by key word per Search History)	4/25/2006	JLL
Discussion with Examiner Queenie Dehghan on inherency and USC 102	4/25/2006	JLL
EAST Search (See search history)	4/25/2006	JLL